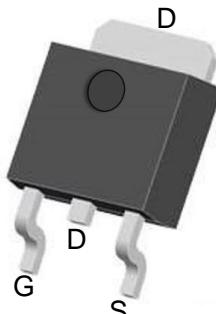


-30V/-60A P-Channel MOSFET**Features**

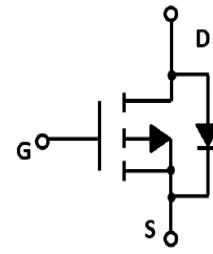
- High density cell design for ultra low $R_{DS(ON)}$
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high EAS

Product Summary

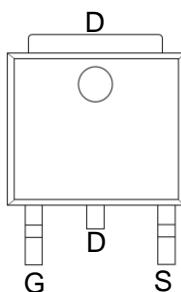
V_{DS}	$R_{DS(ON)} \text{ MAX}$	$I_D \text{ MAX}$
-30V	10mΩ@10V	-60A
	13mΩ@4.5V	



TO-252 top view



Schematic diagram



Marking and pin assignment

Absolute Maximum Ratings (TA=25°C unless otherwise noted)

Symbol	Parameter	Rating	Unit
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Common Ratings (TC=25°C Unless Otherwise Noted)

V_{DS}	Drain-Source Breakdown Voltage	-30	V	
V_{GS}	Gate-Source Voltage	±20	V	
E_{AS}	Single pulse avalanche energy	77	mJ	
T_J, T_{STG}	Storage Temperature Range	-55 to 175	°C	
I_S	Diode Continuous Forward Current	Tc=25°C	-60	A

Mounted on Large Heat Sink

I_{DM}	Pulse Drain Current Tested	Tc=25°C	-210	A
I_D	Continuous Drain Current@GS=10V	Tc=25°C	-60	A
P_D	Maximum Power Dissipation	Tc=25°C	110	W
$R_{θJA}$	Thermal Resistance Junction-Ambient(*1 in2 Pad of 2-oz Copper), Max.)		62.5	°C/W

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Condition	Min	Typ	Max	Unit
Static Electrical Characteristics @ T_J = 25°C (unless otherwise stated)						
BV _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, ID=-250μA	-30	--	--	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-30V, V _{GS} =0V	--	--	-1.0	uA
I _{GSS}	Gate-Body Leakage Current	V _{GS} =±20V, V _{DS} =0V	--	--	±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , ID=-250μA	-1.0	-1.5	-2.2	V
R _{DS(on)}	Drain-Source On-State Resistance	V _{GS} =-10V, ID=15A	--	8.5	10	mΩ
		V _{GS} =-4.5V, ID=8A	--	9.5	13	mΩ

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise stated)

C _{ISS}	Input Capacitance	V _{DS} =-15V, V _{GS} =0V, f=1MHz	--	1988	--	pF
C _{OSS}	Output Capacitance		--	305	--	pF
C _{RSS}	Reverse Transfer Capacitance		--	266	--	pF

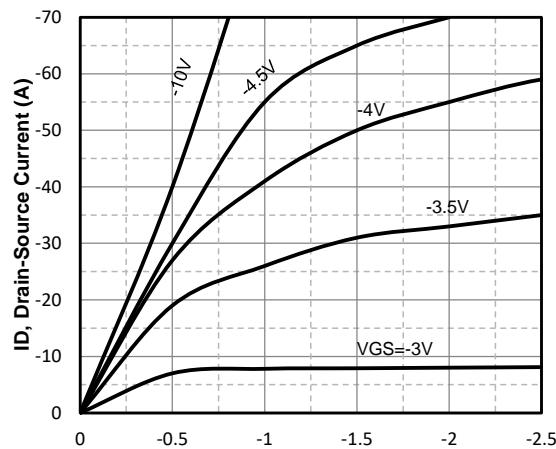
Switching Characteristics

Q _g	Total Gate Charge	VDD=-15V, ID=-12A, VGS=-10V	--	35	--	nC
Q _{gs}	Gate Source Charge		--	5.8	--	nC
Q _{gd}	Gate Drain Charge		--	8.8	--	nC
t _{d(on)}	Turn-on Delay Time	VDD=-15V, ID=-1A, VGS=-10V, RG=2.5Ω	--	11	--	nS
t _r	Turn-on Rise Time		--	7.7	--	nS
t _{d(off)}	Turn-Off Delay Time		--	43.3	--	nS
t _f	Turn-Off Fall Time		--	18	--	nS

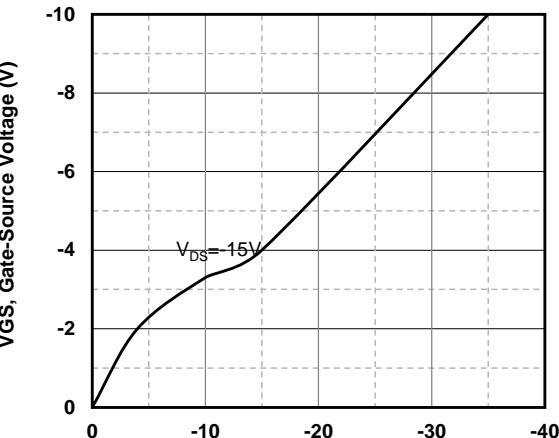
Source- Drain Diode Characteristics

V _{SD}	Forward on voltage	T _j =25°C, I _s =-12A,	--	--	-1.2	V
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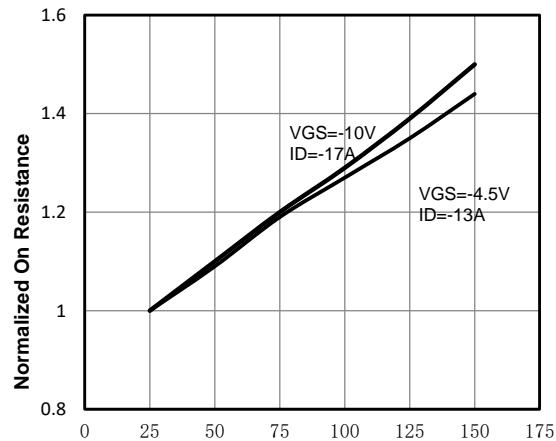
Typical Operating Characteristics



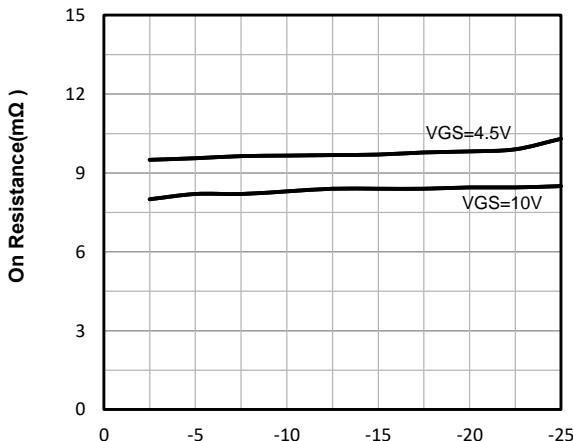
V_{DS}, Drain -Source Voltage (V)
Fig1. Typical Output Characteristics



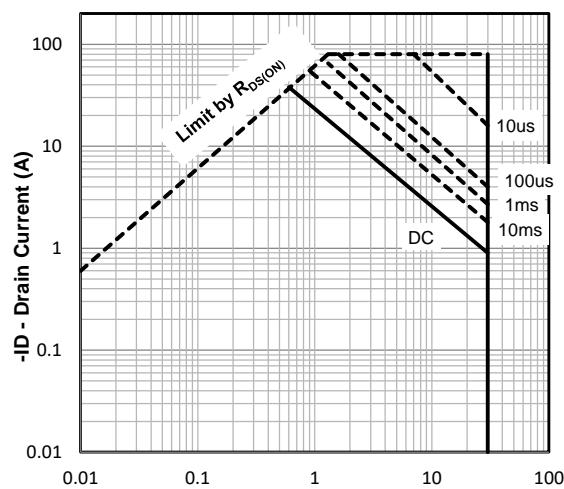
Q_g -Total Gate Charge (nC)
Fig2. Typical Gate Charge Vs.Gate-Source Voltage



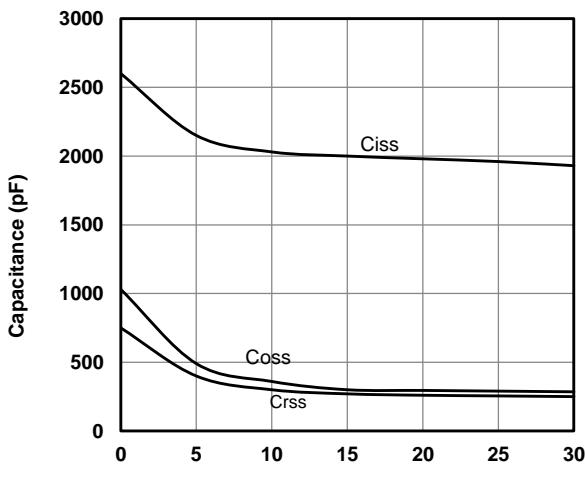
T_j - Junction Temperature (°C)
Fig3. Normalized On-Resistance Vs. Temperature



I_D, Drain-Source Current (A)
Fig4. On-Resistance Vs. Drain-Source Current

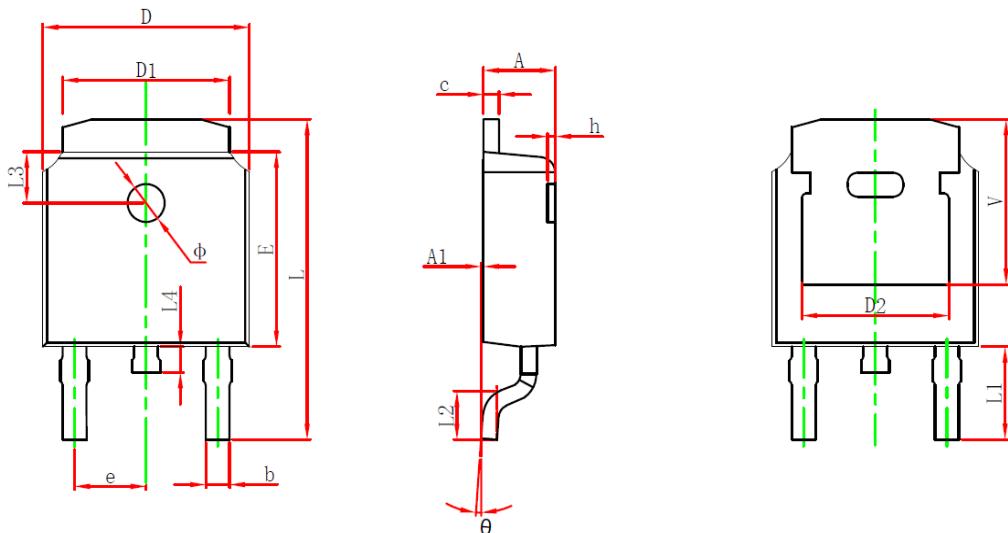


-I_D - Drain Current (A)
-V_{DS}, Drain -Source Voltage (V)
Fig5. Maximum Safe Operating Area



Capacitance (pF)
-V_{DS} , Drain-Source Voltage (V)
Fig6 Typical Capacitance Vs.Drain-Source Voltage

TO-252 Package information



Symbol	Dimensions in Millimeters(mm)		Dimensions In Inches	
	Min	Max	Min	Max
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.635	0.770	0.025	0.030
c	0.450	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.830 REF.		0.190 REF.	
E	6.000	6.200	0.236	0.244
e	2.186	2.386	0.086	0.094
L	9.712	10.312	0.386	0.406
L1	2.900 REF.		0.114 REF.	
L2	1.400	1.700	0.055	0.067
L3	1.600 REF.		0.063 REF.	
L4	0.600	1.000	0.024	0.039
Φ	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.250 REF.		0.207 REF.	